

PATENT NUMBER

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U.S. UTILITY Patent Application

KLU O.I.P.E. 2
 SCANNED 2009 Q.A. CS

PATENT DATE

APPLICATION NO. 09/627456	CONT/PRIOR F	CLASS 356	SUBCLASS 11	ART UNIT 2851	EXAMINER PULZ.
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APPLICANTS

TITLE

Overlay mark, method of measuring overlay accuracy, method of making alignment and semiconductor device therewith

PTO-2040
12/99**ISSUING CLASSIFICATION**[illegible]☐ Continued on Issue Slip Inside File Jacket

<input type="checkbox"/> TERMINAL DISCLAIMER	DRAWINGS		CLAIMS ALLOWED	
	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims
<input type="checkbox"/> The term of this patent subsequent to _____ (date) has been disclaimed.	_____ (Assistant Examiner)		_____ (Date)	
	<input type="checkbox"/> The term of this patent shall not extend beyond the expiration date of U.S Patent. No. _____ _____ _____		NOTICE OF ALLOWANCE MAILED	
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<input type="checkbox"/> The terminal ____ months of this patent have been disclaimed.	_____ (Primary Examiner)		_____ (Date)	
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